

A Measurement Method for Estimating the Average Junction Temperature of AC LEDs

Yi-wei Liu, Terence R. Klein, and N. Narendran

Lighting Research Center
Rensselaer Polytechnic Institute, Troy, NY 12180
www.lrc.rpi.edu

Liu, Y., T.R. Klein, and N. Narendran. 2009. A measurement method for estimating the average junction temperature of AC LEDs. *White LEDs 2009: The Second International Conference on White LEDs and Solid State Lighting*, December 13-16, 2009, Taipei, Taiwan, WB2-3.

Copyright 2009 White LEDs 2009.

This paper is being distributed electronically under the "Fair Use Copyright Act." One print or electronic copy may be made for personal use only. Systematic or multiple reproduction, distribution to multiple locations via electronic or other means, duplication of any material in this paper for a fee or for commercial purposes, or modification of the content of the paper are prohibited under United States and international laws.

A Measurement Method for Estimating the Average Junction Temperature of AC LEDs

Yi-wei Liu, Terence R. Klein, N. Narendran
Lighting Research Center, Rensselaer Polytechnic Institute
21 Union St., Troy, NY 12180 USA
Tel: +1 518 687-7100, Fax: +1 518 687-7120, liuy9@rpi.edu

Abstract — This study investigated a method of estimating the junction temperature of AC LEDs. Laboratory experiment data from a commercial AC LED shows that with increasing junction temperature, the voltage across the LED drops linearly, thus indicating that the proposed method is a promising candidate for estimating AC LED junction temperature.

Introduction

High-power light-emitting diodes (LEDs) have evolved rapidly over the past decade and are now used in a variety of lighting applications. Typically, an LED is a low-voltage direct current (DC) device. Therefore, to power a DC LED, an electronic driver that can convert alternating current (AC) power to DC power is needed. However, for lighting systems, the requirement of an additional component means higher costs and also introduces reliability concerns.

To address these issues, the industry has been developing and marketing AC LEDs, which are now commercially available. The potential benefits of AC LEDs are a reduced number of luminaire parts and a simplified design process.

It is well known that heat at the p-n junction affects LED performance [1–3]. Therefore, methods of measuring LED junction temperature have been widely investigated over the past several decades, especially for DC LEDs [4]. However, few publications to date have addressed the junction temperature measurement of AC LEDs [5, 6].

Experiment

In this study, we investigated a method that could allow for the estimation of AC LED junction temperature by pulsing down an applied reference current with a pulse width of less than several milliseconds, and measuring the voltage at that moment across the device, which has several p-n junctions. A schematic diagram of the experiment apparatus is shown in Figure 1.

This method was chosen because past literature shows that the potential across the junction drops with an increase in junction temperature [7]. In this study, this method will be validated for different types of AC

LEDs, which have different system architectures and circuitry designs.

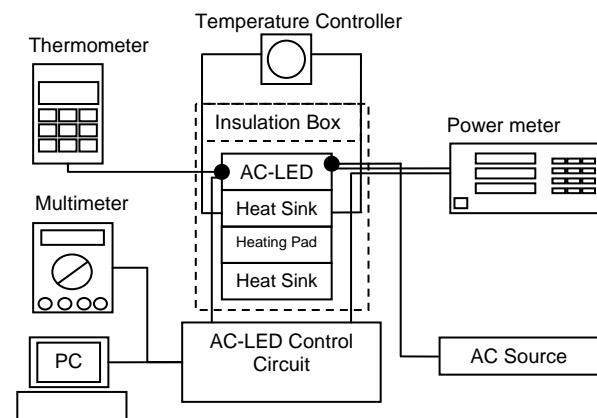


Fig. 1. Schematic of experiment apparatus.

Results

Laboratory experiment data from a commercial AC LED shows that with increasing temperature, the voltage across the LED drops linearly (Figure 2), thus indicating that the proposed method is a promising candidate for estimating AC LED junction temperature.

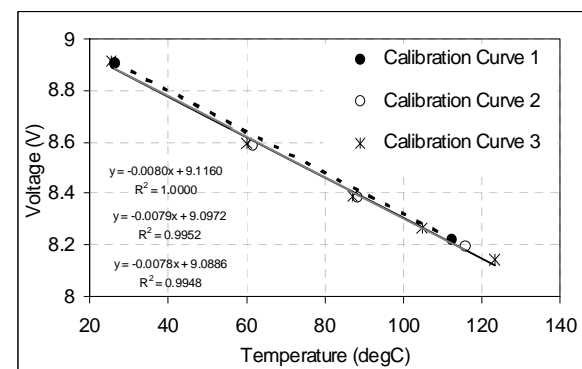


Fig. 2. Data from a commercial AC LED shows that the voltage across the LED drops linearly with increasing junction temperature.

Details regarding the theory, experimental setup and results will be presented in this paper.

REFERENCES

- [1] M. Fukuda, *Reliability and Degradation of Semiconductor Lasers and LEDs*, Artech House, Boston (1991).
- [2] Y. Gu, and N. Narendran, "A non-contact method for determining junction temperature of phosphor-converted white LEDs," *Proc. of SPIE*, (5187), pp. 107-114 (2004).
- [3] N. Narendran, and Y. Gu. "Life of LED-based white light sources," *IEEE/OSA Journal of Display Technology* (1), pp. 167-171 (2005).
- [4] Y. Zong, and Y. Ohno, "New practical method for measurement of high-power LEDs," *Proc. CIE Expert Symposium 2008 on Advances in Photometry and Colorimetry*, (x033), pp. 102-106 (2008).
- [5] Y. Zong, P.T. Chou, M.T. Lin, and Y. Ohno, "Practical method for measurement of AC-driven LEDs at a given junction temperature by using active heat sinks," *Proc. of SPIE*, (7422), pp. 742208-1-6 (2009).
- [6] F.S. Hwu, G.J. Sheu, M.-T. Lin, and J.C. Chen, "Method for determining the junction temperature of alternating current light-emitting diodes," *IET Science, Measurement and Technology*, (3), pp. 159-164 (2009).
- [7] EIA/JEDEC, "Integrated Circuits Thermal Measurement Method – Electrical Test Method (Single Semiconductor Device)," EIA/JESD5101 standard, *Electronic Industries Association*, (1995).